

December 2013

74LCX373 Low Voltage Octal Transparent Latch with 5V Tolerant Inputs and Outputs

Features

- 5V tolerant inputs and outputs
- 2.3V–3.6V V_{CC} specifications provided
- 8.0ns t_{PD} max. (V_{CC} = 3.3V), $10\mu A I_{CC}$ max.
- Power down high impedance inputs and outputs
- Supports live insertion/withdrawal⁽¹⁾
- ± 24 mA output drive ($V_{CC} = 3.0$ V)
- Implements proprietary noise/EMI reduction circuitry
- Latch-up performance exceeds JEDEC 78 conditions
- ESD performance
 - Human body model > 2000V
 - Machine model > 200V
- Leadless DQFN package

Note:

 To ensure the high impedance state during power up or down, OE should be tied to V_{CC} through a pull-up resistor: the minimum value of the resistor is determined by the current-sourcing capability of the driver.

General Description

The LCX373 consists of eight latches with 3-STATE outputs for bus organized system applications. The device is designed for low voltage applications with capability of interfacing to a 5V signal environment.

The LCX373 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

Ordering Information

| Order Number | Package Number | Package Description |
|----------------------------|-------------------|---|
| 74LCX373WM | M20B | 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide |
| 74LCX373SJ | M20D | 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74LCX373BQX ⁽²⁾ | MLP20B | 20-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 4.5mm |
| 74LCX373MSA | MSA20 | 20-Lead Shrink Small Outline Package (SSOP), JEDEC MO-150, 5.3mm Wide |
| 74LCX373MTC | MTC20 | 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |

Note:

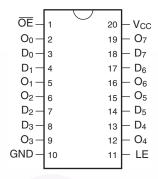
2. DQFN package available in Tape and Reel only.

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

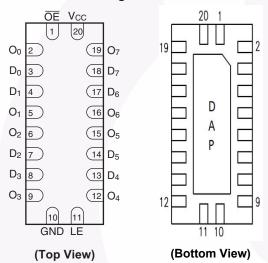
All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagrams

Pin Assignments for SOIC, SOP, SSOP, TSSOP



Pad Assignments for DQFN

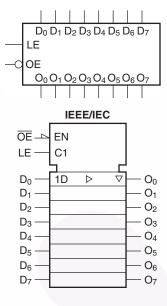


Pin Descriptions

| Pin Names | Description | |
|--------------------------------|-----------------------------|--|
| D ₀ –D ₇ | Data Inputs | |
| LE | Latch Enable Input | |
| ŌĒ | 3-STATE Output Enable Input | |
| O ₀ -O ₇ | 3-STATE Latch Outputs | |
| DAP | No Connect | |

Note: DAP (Die Attach Pad)

Logic Symbols



Truth Table

| | Inputs | | |
|----|--------|----------------|----------------|
| LE | ŌĒ | D _n | On |
| X | Н | Х | Z |
| Н | L | L | L |
| Н | L | Н | Н |
| L | L | Х | O ₀ |

H = HIGH Voltage

L = LOW Voltage

Z = High Impedance

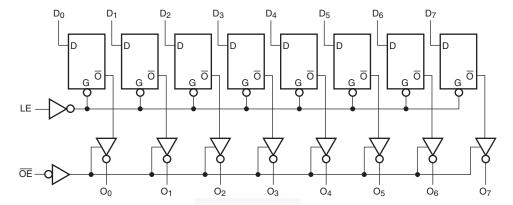
X = Immaterial

 ${\rm O_0}$ = Previous ${\rm O_0}$ before HIGH-to-LOW transition of Latch Enable

Functional Description

The LCX373 contains eight D-type latches with 3-STATE standard outputs. When the Latch Enable (LE) input is HIGH, data on the D_n inputs enters the latches. In this condition the latches are transparent, i.e. a latch output will change state each time its D input changes. When LE is LOW, the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The 3-STATE standard outputs are controlled by the Output Enable $(\overline{\mathsf{OE}})$ input. When $\overline{\mathsf{OE}}$ is LOW, the standard outputs are in the 2-state mode. When $\overline{\mathsf{OE}}$ is HIGH, the standard outputs are in the high impedance mode but this does not interfere with entering new data into the latches.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

| Symbol | Parameter | Conditions | Value | Units |
|------------------|----------------------------------|--|--------------------------|-------|
| V _{CC} | Supply Voltage | | -0.5 to +7.0 | V |
| V _I | DC Input Voltage | | -0.5 to +7.0 | V |
| Vo | DC Output Voltage | Output in 3-STATE | -0.5 to +7.0 | V |
| | | Output in HIGH or LOW State ⁽³⁾ | -0.5 to $V_{CC} + 0.5$ | |
| I _{IK} | DC Input Diode Current | V _I < GND | -50 | mA |
| I _{OK} | DC Output Diode Current | V _O < GND | -50 | mA |
| | | $V_O > V_{CC}$ | +50 | |
| Io | DC Output Source/Sink Current | | ±50 | mA |
| I _{CC} | DC Supply Current per Supply Pin | | ±100 | mA |
| I _{GND} | DC Ground Current per Ground Pin | | ±100 | mA |
| T _{STG} | Storage Temperature | | -65 to +150 | °C |

Recommended Operating Conditions⁽⁴⁾

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

| Symbol | Parameter | Conditions | Min. | Max. | Units |
|----------------------------------|--------------------------------|---------------------------------------|------|-----------------|-------|
| V _{CC} | Supply Voltage | Operating | 2.0 | 3.6 | V |
| | | Data Retention | 1.5 | 3.6 | |
| V _I | Input Voltage | | 0 | 5.5 | V |
| V _O | Output Voltage | HIGH or LOW State | 0 | V _{CC} | V |
| | | 3-STATE | 0 | 5.5 | |
| I _{OH} /I _{OL} | Output Current | $V_{CC} = 3.0V - 3.6V$ | | ±24 | mA |
| | | $V_{CC} = 2.7V - 3.0V$ | | ±12 | |
| | | $V_{CC} = 2.3V - 2.7V$ | / | ±8 | |
| T _A | Free-Air Operating Temperature | | -40 | 85 | °C |
| Δt/ΔV | Input Edge Rate | $V_{IN} = 0.8V - 2.0V, V_{CC} = 3.0V$ | 0 | 10 | ns/V |

Notes:

- 3. I_O Absolute Maximum Rating must be observed.
- 4. Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

| | | | | $T_A = -40^{\circ}C$ | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | | |
|------------------|---------------------------------------|---------------------|--|-----------------------|---|-------|--|
| Symbol | Parameter | V _{CC} (V) | Conditions | Min. | Max. | Units | |
| V _{IH} | HIGH Level Input Voltage | 2.3–2.7 | | 1.7 | | V | |
| | | 2.7–3.6 | | 2.0 | | | |
| V _{IL} | LOW Level Input Voltage | 2.3–2.7 | | | 0.7 | V | |
| | | 2.7–3.6 | | | 0.8 | | |
| V _{OH} | HIGH Level Output Voltage | 2.3-3.6 | $I_{OH} = -100 \mu A$ | V _{CC} - 0.2 | | V | |
| | | 2.3 | $I_{OH} = -8mA$ | 1.8 | | | |
| | | 2.7 | $I_{OH} = -12mA$ | 2.2 | | I | |
| | | 3.0 | $I_{OH} = -18mA$ | 2.4 | | | |
| | | 3.0 | $I_{OH} = -24mA$ | 2.2 | | | |
| V _{OL} | LOW Level Output Voltage | 2.3-3.6 | I _{OL} = 100μA | | 0.2 | V | |
| | | 2.3 | I _{OL} = 8mA | | 0.6 | | |
| | | 2.7 | I _{OL} = 12mA | | 0.4 | | |
| | | 3.0 | I _{OL} = 16mA | | 0.4 | | |
| | | 3.0 | I _{OL} = 24mA | | 0.55 | | |
| I _I | Input Leakage Current | 2.3-3.6 | $0 \le V_I \le 5.5V$ | | ±5.0 | μA | |
| I _{OZ} | 3-STATE Output Leakage | 2.3–3.6 | $0 \le V_O \le 5.5V$, $V_I = V_{IH}$ or V_{IL} | | ±5.0 | μА | |
| I _{OFF} | Power-Off Leakage Current | 0 | V_I or $V_O = 5.5V$ | | 10 | μA | |
| I _{CC} | Quiescent Supply Current | 2.3–3.6 | $V_I = V_{CC}$ or GND | | 10 | μA | |
| | | 2.3–3.6 | $3.6V \le V_I, V_O \le 5.5V^{(5)}$ | | ±10 | | |
| ΔI_{CC} | Increase in I _{CC} per Input | 2.3-3.6 | $V_{IH} = V_{CC} - 0.6V$ | | 500 | μΑ | |

AC Electrical Characteristics

| | | $T_A = -40$ °C to +85°C, $R_L = 500\Omega$ | | | | | | |
|---------------------------------------|---|--|---|------|--|------|--|-------|
| | | | $V_{CC} = 3.3V \pm 0.3V,$ $C_{L} = 50pF$ | | V _{CC} = 2.7V, C _L = 50pF | | $V_{CC} = 2.5 \pm 0.2V,$ $C_{L} = 30pF$ | |
| Symbol | Parameter | Min. | Max. | Min. | Max. | Min. | Max. | Units |
| t _{PHL} , t _{PLH} | Propagation Delay, D _n to O _n | 1.5 | 8.0 | 1.5 | 9.0 | 1.5 | 9.6 | ns |
| t _{PHL} , t _{PLH} | Propagation Delay, LE to O _n | 1.5 | 8.5 | 1.5 | 9.5 | 1.5 | 10.5 | ns |
| t_{PZL}, t_{PZH} | Output Enable Time | 1.5 | 8.5 | 1.5 | 9.5 | 1.5 | 10.5 | ns |
| t _{PLZ} , t _{PHZ} | Output Disable Time | 1.5 | 7.5 | 1.5 | 8.5 | 1.5 | 9.0 | ns |
| t _S | Setup Time, D _n to LE | 2.5 | | 2.5 | | 4.0 | | ns |
| t _H | Hold Time, D _n to LE | 1.5 | | 1.5 | | 2.0 | | ns |
| t _W | LE Pulse Width | 3.3 | | 3.3 | | 4.0 | | ns |
| t _{OSHL} , t _{OSLH} | Output to Output Skew ⁽⁶⁾ | | 1.0 | | | | | ns |

Notes:

- 5. Outputs disabled or 3-STATE only.
- 6. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

Dynamic Switching Characteristics

| | | | | T _A = 25°C | |
|------------------|---|---------------------|--|-----------------------|-------|
| Symbol | Parameter | V _{CC} (V) | Conditions | Typical | Units |
| V _{OLP} | Quiet Output Dynamic Peak V _{OL} | 3.3 | $C_L = 50pF, V_{IH} = 3.3V, V_{IL} = 0V$ | 0.8 | V |
| | | 2.5 | $C_L = 30pF, V_I = 2.5V, V_{IL} = 0V$ | 0.6 | |
| V _{OLV} | Quiet Output Dynamic Valley V _{OL} | 3.3 | $C_L = 50pF, V_{IH} = 3.3V, V_{IL} = 0V$ | -0.8 | V |
| | | 2.5 | $C_L = 30pF, V_I = 2.5V, V_{IL} = 0V$ | -0.6 | |

Capacitance

| Symbol | Parameter | Conditions | Typical | Units |
|------------------|-------------------------------|--|---------|-------|
| C _{IN} | Input Capacitance | V_{CC} = Open, V_I = 0V or V_{CC} | 7 | pF |
| C _{OUT} | Output Capacitance | $V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC} | 8 | pF |
| C _{PD} | Power Dissipation Capacitance | $V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC} , $f = 10MHz$ | 25 | рF |

AC Loading and Waveforms (Generic for LCX Family)

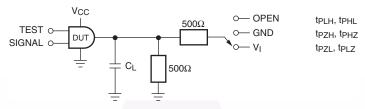
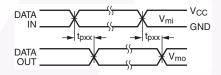
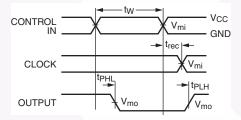


Figure 1. AC Test Circuit (C_L includes probe and jig capacitance)

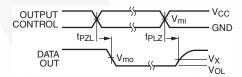
| Test | Switch | |
|-------------------------------------|---|--|
| t _{PLH} , t _{PHL} | Open | |
| t _{PZL} , t _{PLZ} | 6V at $V_{CC} = 3.3 \pm 0.3V$ $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$ | |
| t _{PZH} , t _{PHZ} | GND | |



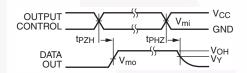
Waveform for Inverting and Non-Inverting Functions



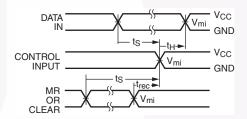
Propagation Delay, Pulse Width and t_{rec} Waveforms



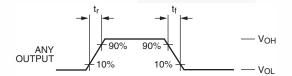
3-STATE Output Low Enable and Disable Times for Logic



3-STATE Output High Enable and Disable Times for Logic



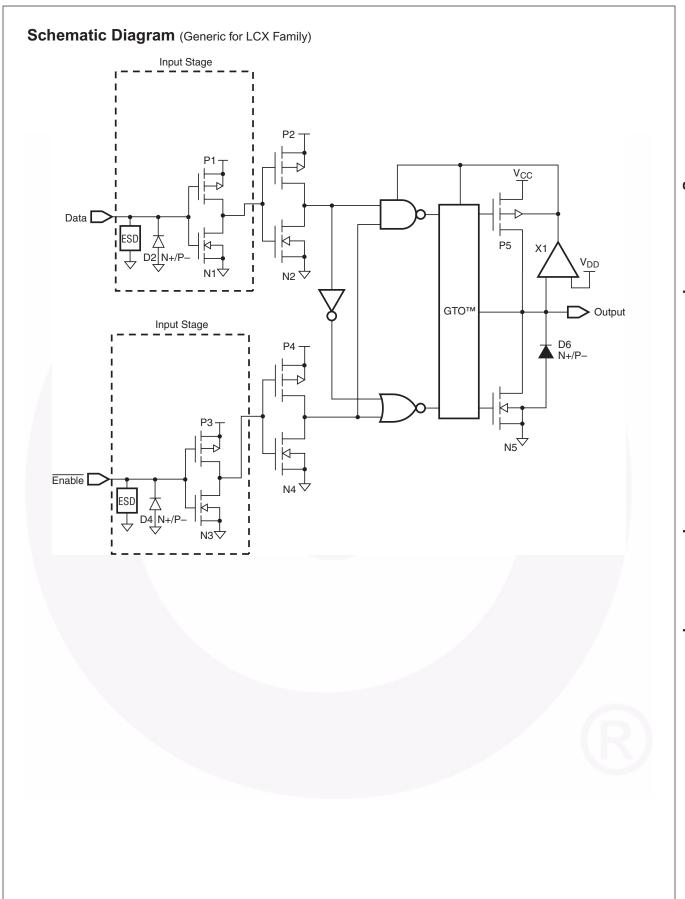
Setup Time, Hold Time and Recovery Time for Logic



 t_{rise} and t_{fall}

Figure 2. Waveforms (Input Characteristics; f = 1MHz, $t_r = t_f = 3ns$)

| | V _{CC} | | | |
|-----------------|------------------------|------------------------|-------------------------|--|
| Symbol | 3.3V ± 0.3V | 2.7V | 2.5V ± 0.2V | |
| V _{mi} | 1.5V | 1.5V | V _{CC} / 2 | |
| V_{mo} | 1.5V | 1.5V | V _{CC} / 2 | |
| V_x | V _{OL} + 0.3V | V _{OL} + 0.3V | V _{OL} + 0.15V | |
| V _y | V _{OH} – 0.3V | V _{OH} – 0.3V | V _{OH} – 0.15V | |

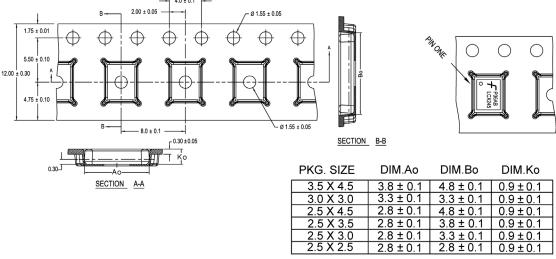


Tape and Reel Specification

Tape Format for DQFN

| Package Designator | Tape Section | Number Cavities | Cavity Status | Cover Tape Status |
|-----------------------|--------------------|--------------------|------------------|----------------------|
| BQX | Leader (Start End) | 125 (typ) | Empty | Sealed |
| | Carrier | 3000 | Filled | Sealed |
| | Trailer (Hub End) | 75 (typ) | Empty | Sealed |

Tape Dimensions inches (millimeters)

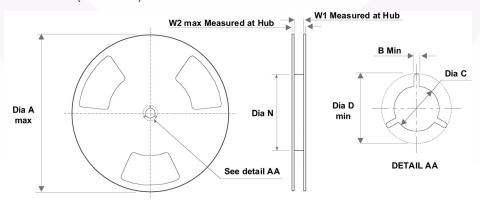


DIMENSIONS ARE IN MILLIMETERS

NOTES: unless otherwise specified

- 1. Cummulative pitch for feeding holes and cavities (chip pockets) not to exceed 0.008[0.20] over 10 pitch span.
- 2. Smallest allowable bending radius.
- 3. Thru hole inside cavity is centered within cavity.
- 4. Tolerance is ±0.002[0.05] for these dimensions on all 12mm tapes.
- 5. Ao and Bo measured on a plane 0.120[0.30] above the bottom of the pocket.
- 6. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
- 7. Pocket position relative to sprocket hole measured as true position of pocket. Not pocket hole.
- 8. Controlling dimension is millimeter. Diemension in inches rounded.

Reel Dimensions inches (millimeters)



| Tape Size | Α | В | С | D | N | W1 | W2 |
|-----------|--------------|--------------|---------------|---------------|---------------|--------------|--------------|
| 12mm | 13.0 (330.0) | 0.059 (1.50) | 0.512 (13.00) | 0.795 (20.20) | 2.165 (55.00) | 0.488 (12.4) | 0.724 (18.4) |

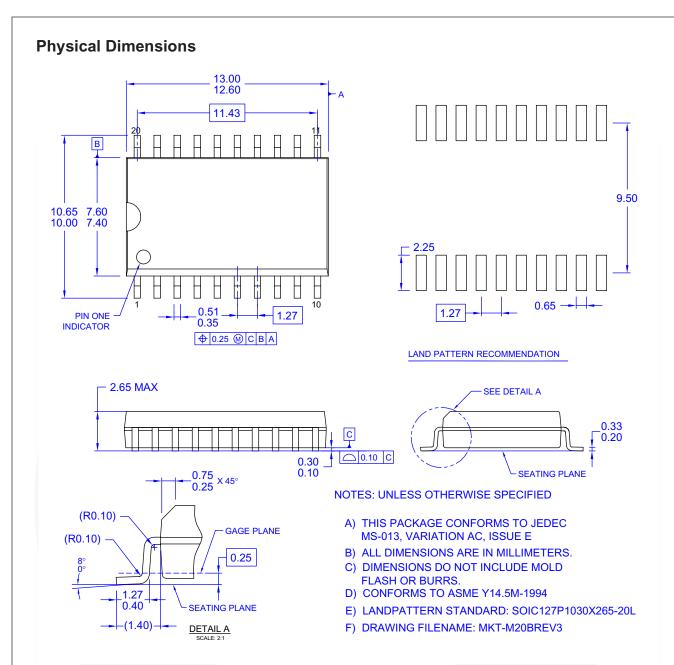
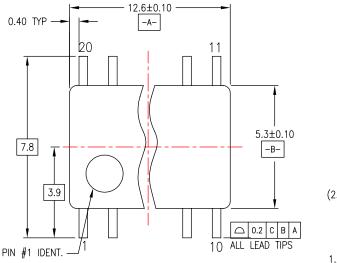
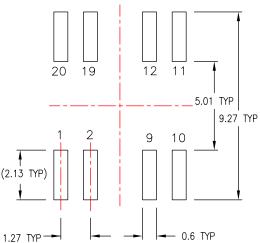


Figure 3. 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide

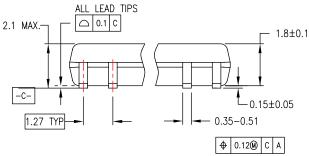
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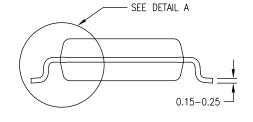
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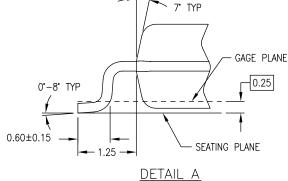


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NOTES:

- A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.

 B. DIMENSIONS ARE IN MILLIMETERS.
 C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.



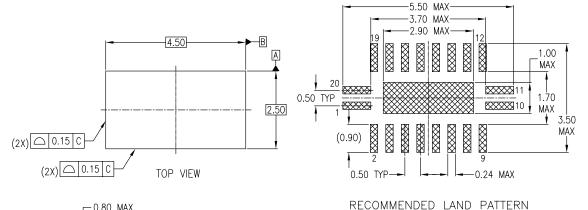
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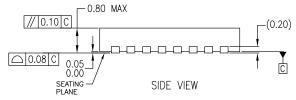
Figure 4. 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide

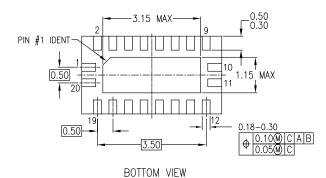
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NOTES:

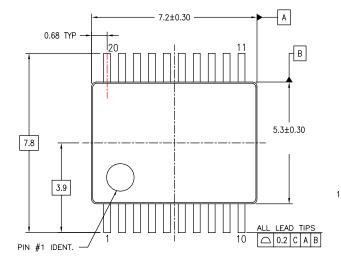
- A. CONFORMS TO JEDEC REGISTRATION MO-241, VARIATION AC
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

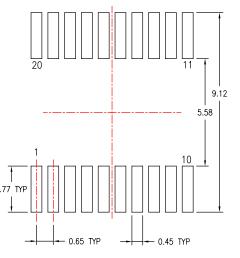
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Figure 5. 20-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 4.5mm

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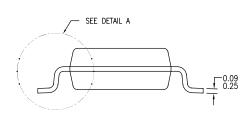
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LAND PATTERN RECOMMENDATIONS

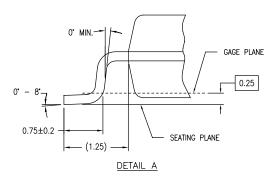
2.0 MAX. 1.75±0.04 0.65 TYP 0.22-0.38 0.13±0.08



DIMENSIONS ARE IN MILLIMETERS

NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-150, VARIATION AE, DATE 1/94.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ASME Y14.5M 1994.

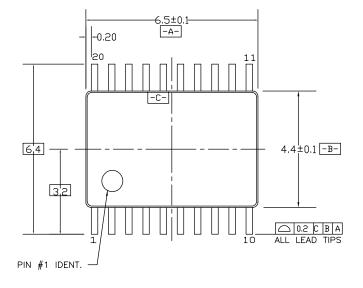


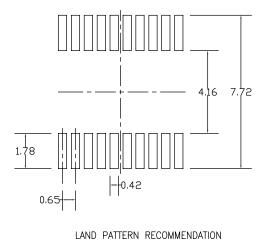
MSA20REVB

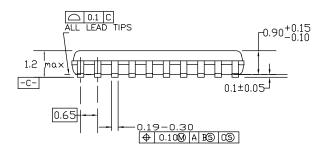
Figure 6. 20-Lead Shrink Small Outline Package (SSOP), JEDEC MO-150, 5.3mm Wide

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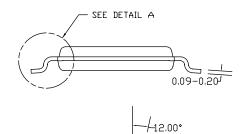


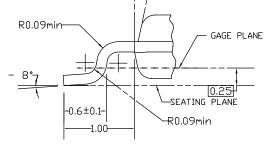


DIMENSIONS ARE IN MILLIMETERS

NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MD-153, VARIATION AC, REF NOTE 6, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLDS FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.





DETAIL A

MTC20REVD1

Figure 7. 20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

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